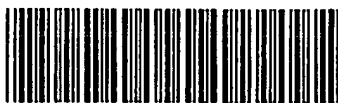


Search Notes



Application/Control No.

10/624,689

Examiner

Mark A. Chapman

Applicant(s)/Patent under
Reexamination

KOBAYASHI ET AL.

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner
430	124	6/10/2005	MC
	97		
	48		
	56		
369	272.1		
	273		
428	412		
	480		
	483		
<i>update</i>		<i>12/05 mc</i>	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
<i>428</i>	<i>412</i>	<i>12/05 mc</i>	
	<i>480, 483</i>		
<i>430</i>	<i>124, 97</i>		
	<i>48, 56</i>		
<i>369</i>	<i>272.1, 273</i>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
east	6/10/2005	MC
reviewed related application		
<i>update</i>	<i>12/05 mc</i>	